

## LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

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APPLICATION NO.

09/540,952

APPLICANT

Waldspurger et al.

FILING DATE

March 31, 2000

GROUP

Unknown

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EXAMINER

Chuck Kendall

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\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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